NTK3142P

Small Signal MOSFET

−20 V, −280 mA, P−Channel with ESD Protection, SOT−723

Features

- Enables High Density PCB Manufacturing
- 44% Smaller Footprint than SC−89 and 38% Thinner than SC−89
- Low Voltage Drive Makes this Device Ideal for Portable Equipment
- Low Threshold Levels, 1.8 V $R_{DS(on)}$ Rating
- Low Profile (< 0.5 mm) Allows It to Fit Easily into Extremely Thin Environments such as Portable Electronics
- Operated at Standard Logic Level Gate Drive, Facilitating Future Migration to Lower Levels Using the Same Basic Topology.
- This is a Pb−Free Device

Applications

- Interfacing, Switching
- High Speed Switching
- Cellular Phones, PDA's

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain−to−Source Voltage			V_{DSS}	−20	V
Gate−to−Source Voltage			V_{GS}	±8.0	V
Continuous Drain Current (Note 1)	Steady State	T_A = 25°C	I_D	−260	mA
		T_A = 85°C		−185	
	t ≤ 5 s	T_A = 25°C		−280	
Power Dissipation (Note 1)	Steady State	T_A = 25°C	P_D	400	mW
	t ≤ 5 s			500	
Continuous Drain Current (Note 2)	Steady State	T_A = 25°C	I_D	−215	mA
		T_A = 85°C		−155	
Power Dissipation (Note 2)		T_A = 25°C	P_D	280	mW
Pulsed Drain Current	t_p = 10 μs		I_{DM}	−310	mA
Operating Junction and Storage Temperature			T_J, T_{STG}	−55 to 150	°C
Source Current (Body Diode) (Note 2)			I_S	−240	mA
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T_L	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

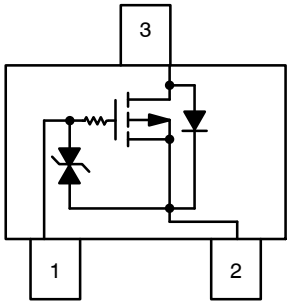
1. Surface−mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
2. Surface−mounted on FR4 board using the minimum recommended pad size.

ON Semiconductor®

http://onsemi.com

$V_{(BR)DSS}$	$R_{DS(on)}$ TYP	I_D Max
−20 V	2.7 Ω @ −4.5 V	−280 mA
	4.1 Ω @ −2.5 V	
	6.1 Ω @ −1.8 V	

SOT−723 (3−LEAD)



Top View

1 − Gate
2 − Source
3 − Drain

CASE 631AA
SOT−723

MARKING DIAGRAM

KB = Specific Device Code
M = Date Code

ORDERING INFORMATION

Device	Package	Shipping†
NTK3142PT1G	SOT−723 (Pb−Free)	4000/Tape & Reel 4 mm Pitch
NTK3142PT5G	SOT−723 (Pb−Free)	8000/Tape & Reel 2 mm Pitch

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction−to−Ambient − Steady State (Note 3)	$R_{\theta JA}$	315	°C/W
Junction−to−Ambient − t = 5 s (Note 3)	$R_{\theta JA}$	250	
Junction−to−Ambient − Steady State Minimum Pad (Note 4)	$R_{\theta JA}$	440	

3. Surface−mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
4. Surface−mounted on FR4 board using the minimum recommended pad size.

MOSFET ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Typ	Max	Unit
OFF CHARACTERISTICS							
Drain−to−Source Breakdown Voltage	$V_{(BR)DSS}$	V_{GS} = 0 V, I_D = −100 μA		−20			V
Drain−to−Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$	I_D = −100 μA, Reference to 25°C			14		mV/°C
Zero Gate Voltage Drain Current	I_{DSS}	V_{GS} = 0 V, V_{DS} = −16 V	T_J = 25°C			−1.0	μA
			T_J = 125°C			−2.0	
Gate−to−Source Leakage Current	I_{GSS}	V_{DS} = 0 V, V_{GS} = ±5 V				±1	μA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	$V_{GS(TH)}$	V_{GS} = V_{DS}, I_D = −250 μA		−0.4		−1.3	V
Gate Threshold Temperature Coefficient	$V_{GS(TH)}/T_J$				−2.0		mV/°C
Drain−to−Source On Resistance	$R_{DS(ON)}$	V_{GS} = −4.5V, I_D = −260 mA			2.9	4.0	Ω
Drain−to−Source On Resistance	$R_{DS(ON)}$	V_{GS} = −4.5V, I_D = −10 mA			2.7	3.4	Ω
		V_{GS} = −2.5 V, I_D = −1 mA			4.1	5.3	
		V_{GS} = −1.8 V, I_D = −1 mA			6.1	10	
Forward Transconductance	g_{FS}	V_{DS} = −5 V, I_D = −10 mA			73		mS
CAPACITANCES							
Input Capacitance	C_{ISS}	V_{GS} = 0 V, f = 1 MHz, V_{DS} = −10 V			15.3		pF
Output Capacitance	C_{OSS}				4.3		
Reverse Transfer Capacitance	C_{RSS}				2.3		
SWITCHING CHARACTERISTICS, V_{GS} = 4.5 V (Note 6)							
Turn−On Delay Time	$t_{d(ON)}$	V_{GS} = −4.5 V, V_{DD} = −5 V, I_D = −100 mA, R_G = 6 Ω			8.4	16	ns
Rise Time	t_r				15.3	28	
Turn−Off Delay Time	$t_{d(OFF)}$				37.5	80	
Fall Time	t_f				22.7	43	
DRAIN−SOURCE DIODE CHARACTERISTICS							
Forward Diode Voltage	V_{SD}	V_{GS} = 0 V, I_S= −10 mA	T_J = 25°C		0.69	−1.2	V
			T_J = 125°C		0.56		
Reverse Recovery Time	t_{RR}	V_{GS} = 0 V, V_{DD} = −20 V, dI_{SD}/dt = 100 A/μs, I_S = −1.0 A			37	80	ns
Charge Time	t_a				15.9	30	
Discharge Time	t_b				21.1	50	
Reverse Recovery Charge	Q_{RR}				20	70	nC

5. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

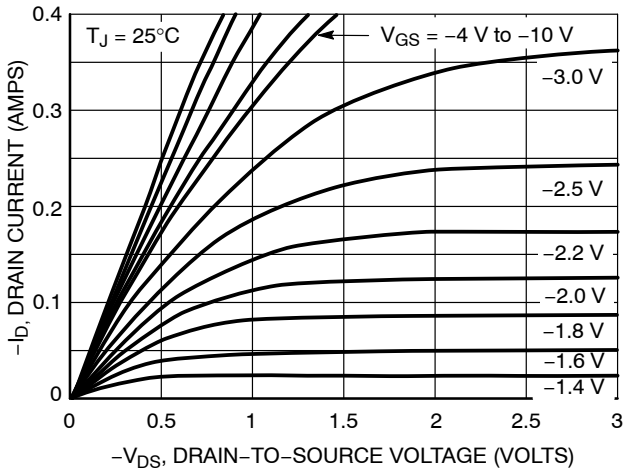


Figure 1. On−Region Characteristics

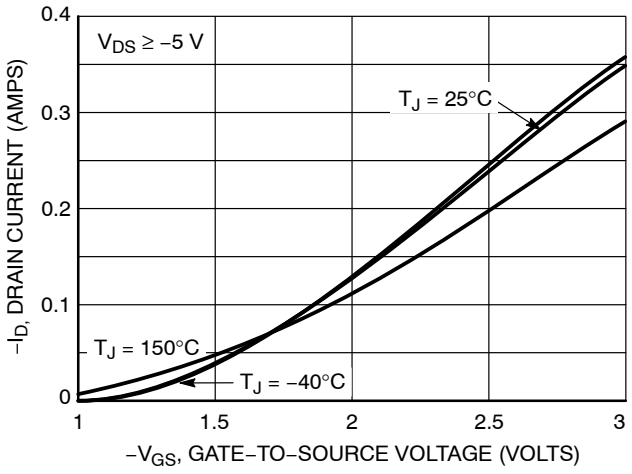


Figure 2. Transfer Characteristics

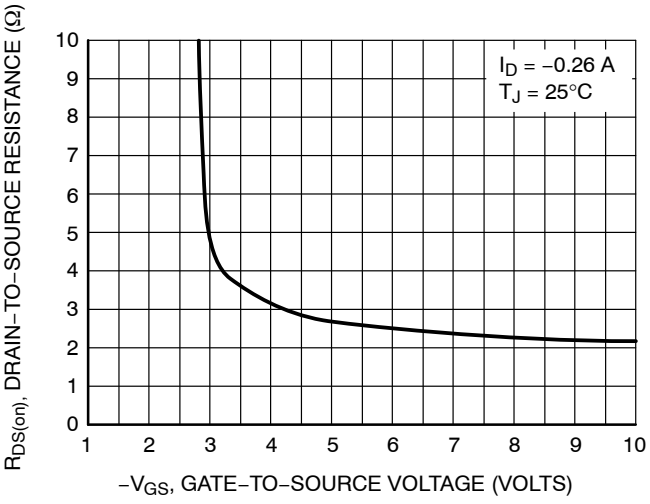


Figure 3. On−Resistance vs. Gate−to−Source Voltage

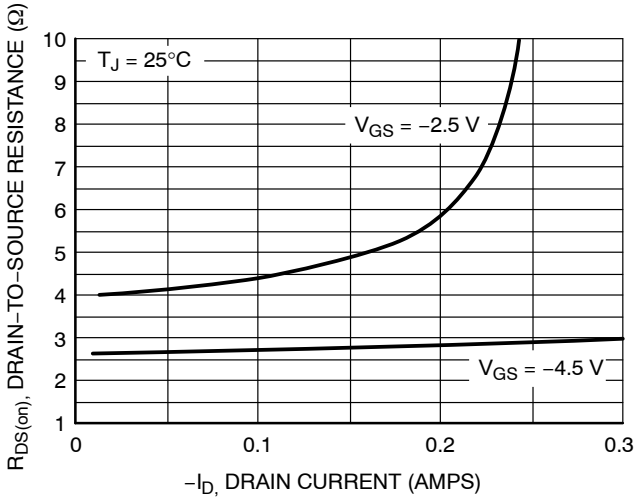


Figure 4. On−Resistance vs. Drain Current and Gate Voltage

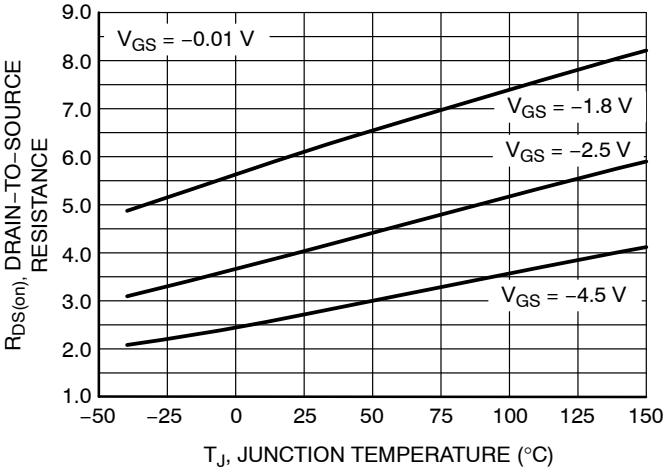


Figure 5. On−Resistance Variation with Temperature

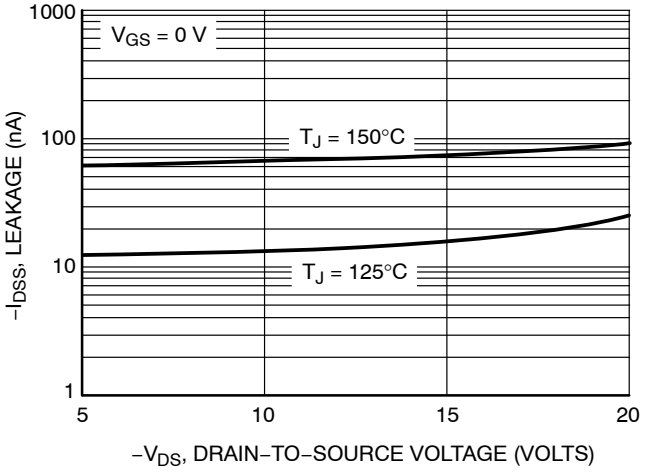


Figure 6. Drain−to−Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CURVES

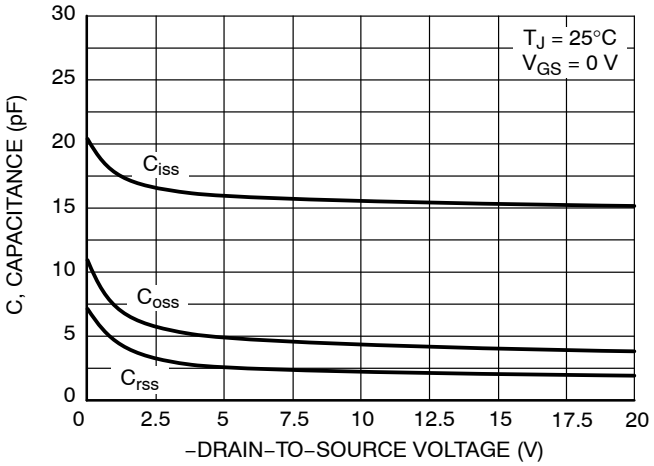


Figure 7. Capacitance Variation

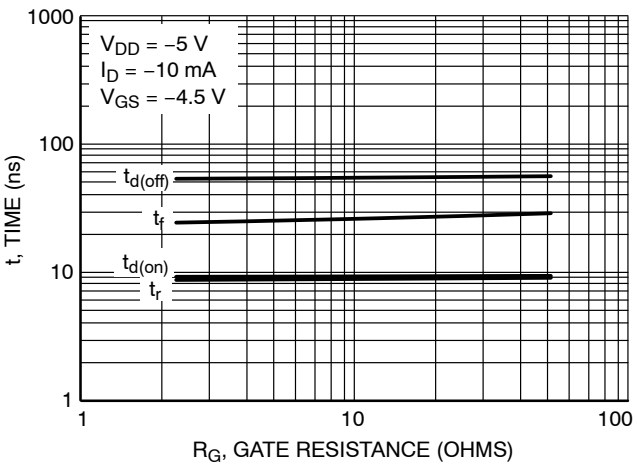


Figure 8. Resistive Switching Time Variation vs. Gate Resistance

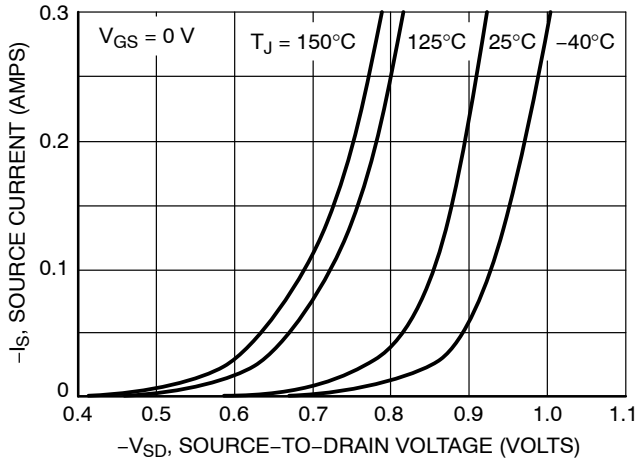
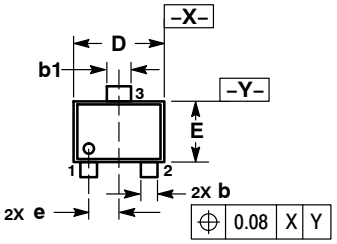


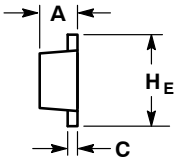
Figure 9. Diode Forward Voltage vs. Current

PACKAGE DIMENSIONS

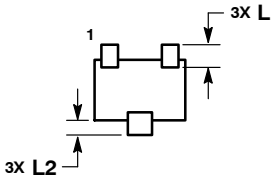
SOT−723
CASE 631AA−01
ISSUE D



TOP VIEW



SIDE VIEW



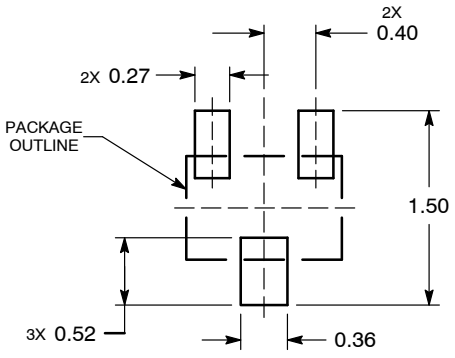
BOTTOM VIEW

NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.

	MILLIMETERS		
DIM	MIN	NOM	MAX
A	0.45	0.50	0.55
b	0.15	0.21	0.27
b1	0.25	0.31	0.37
C	0.07	0.12	0.17
D	1.15	1.20	1.25
E	0.75	0.80	0.85
e	0.40 BSC		
H E	1.15	1.20	1.25
L	0.29 REF		
L2	0.15	0.20	0.25

STYLE 3:
PIN 1. ANODE
2. ANODE
3. CATHODE

RECOMMENDED SOLDERING FOOTPRINT*



DIMENSIONS: MILLIMETERS

*For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:
Literature Distribution Center for ON Semiconductor
P.O. Box 5163, Denver, Colorado 80217 USA
Phone: 303−675−2175 or 800−344−3860 Toll Free USA/Canada
Fax: 303−675−2176 or 800−344−3867 Toll Free USA/Canada
Email: orderlit@onsemi.com

N. American Technical Support: 800−282−9855 Toll Free USA/Canada
Europe, Middle East and Africa Technical Support:
Phone: 421 33 790 2910
Japan Customer Focus Center
Phone: 81−3−5773−3850

ON Semiconductor Website: **www.onsemi.com**

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative